## A Study on the Deposition Conditions of the TiNi Thin Film by DC Magnetron Sputtering

Dae-Cheol Choi, Beom-Gyo Han, Tae-Hyun Nam, and Hyo-Jun Ahn

Department of Metallurgical & Materials Engineering, Gyeongsang National University, Research Center for Aircraft Parts Technology

# DC 마그네트론 스퍼터링법에 의해 제조한 TiNi 박막의 중착조건에 관한 연구

최대철, 한범교, 남태현, 안효준

경상대학교 재료공학부, 항공기부품기술연구소

#### Abstract

In order to investigate the possibilities of microbatteries using TiNi type metal hydride, TiNi films were prepared by DC magnetron sputtering. The films were deposited under various Ar flow rates, DC powers and target-to-substrate distances to find the optimum sputtering conditions. The deposition rate of TiNi thin film increased by increasing the DC power and by decreasing the Ar flow rate and target-to-substrate distance. The chemical composition of the film changed as a target-to-substrate distance. The crystal structure of the film was amorphous state just after deposition and changed to crystalline by vacuum heat treatment.

#### 수소에너지 제 10권 제 4호(1999년 12월)

#### 초 록

수소저장합금 전극을 이용하는 박막전지의 제조를 위하여, TiNi 수소저장합금박막의 적정제조조건에 대하여 연구하였다. TiNi합금박막은 직류 스퍼터링을 이용하여 제조하였다. 중착변수인 아르곤유속, 타켙-기판거리, 직류 전력량등을 변화시키면서, 증착속도를 조사하였으며, Ti와 Ni의 화학조성비, 결정구조등을 조사하였다. 증착속도는 아르곤유속, 타겥-기판거리와 반비례하였으며, 직류전력량의 증가에는 정비례하여 증가하였다. 상온에서 증착후에는 비정질구조를 나타냈으나, 진공열처리 후에 결정질로 바뀌었다.

#### 1. Introduction

Metal hydrides are promising materials for the hydrogen storage, chemical heat pump, hydrogen purification and Ni/MH battery<sup>(1)</sup>. Especially, Ni/MH batteries have been popular in the commercial market. There are many metal hydrides such as LaNi<sub>5</sub> type, Mg<sub>2</sub>Ni type, Zr(Ti)Ni<sub>2</sub> type and TiNi type for the negative electrode material of Ni/MH batteries. Recently, microbatteries using thin film electrode have been interest as a power source of MEMS(micro electromechanical system) and smart cards<sup>(2)</sup>. A lot of researchers have been working on the Li ion microbatteries (2,3), but only a few papers were published in the field of MH microbatteries. Sakai et al (4) reported that the discharge capacities of LaNi5 thin film electrode of amorphous and crystalline showed 40mAh/g, 160mAh/g, respectively. Kuriyama et al<sup>(5)</sup> made a microcell such LaNi<sub>2.5</sub>Co<sub>2.4</sub>Al<sub>0.1</sub>/TMAOH<sub>5</sub>/NiOOH(or  $MnO_2$ ), and tested it up to 200 cycles. In

the thin film type MH electrode, one of the severe problem was disintegration of the film during hydrogenation. TiNi alloy was a well known as shape memory alloy as well as hydrogen storage material. And also, TiNi alloy was not brittle but tough in mechanical properties. So TiNi thin film are considered as a potential electrode material for Ni/MH Only a few papers have microbatteries. been published in the fabrication of TiNi thin film (6,7), and there was no paper on the deposition rates as the sputtering conditions.

In this paper, we studied the fabrication conditions of TiNi thin film using DC magnetron sputter and the electrochemical properties of TiNi electrode.

### 2. Experimental

The TiNi thin films were deposited by DC magnetron sputtering. The  ${\rm Ti}_{60}{\rm Ni}_{40}$  target was made by VIM(vacuum

#### 최대철, 한범교, 남태현, 안효준

induction melting). The diameter of target is 2 inch. The stainless steel and glass sheet was used as the substrate. The ultimate and the deposition pressure were  $5 \times 10^{-6}$ Torr and  $1 \sim 6$  mTorr, respectively. In order to obtain the optimum sputtering TiNi thin film, we have condition for changed the Ar flow rates  $(1 \sim 12 \text{ sccm})$ , distances between the target and  $(10 \sim 23 \text{cm})$ , DC power(50~ substrate 250watt). For the crystallization of thin film, the vacuum heat treatments were performed from 600 to 800℃. The electrochemical test of TiNi thin film electrode were conducted in a 6M KOH solution with Hg/HgO reference electrode, Pt counter electrode. The cutoff voltage on charge 3.0V and for discharge was 0.5V vs Hg/HgO reference electrode. TiNi thin film electrode was charged in a density of  $0.032 \text{mA/cm}^2$ current and 0.016mA/cm² for discharge. In order to comparison with thin film type electrodes, TiNi powder electrodes were prepared using mixed powder of TiNi and Ni in a weight ratio of 1:3. And, it was cold pressed with a compacting pressure of 5 tons/cm, and then wrapped in the Ni mesh as a current collector. TiNi powder electrode was charged in a current density of 100mA/g and 200mA/g for discharge. For the study on the deposition rate of thin film, the thickness of film The crystal was measured by a-step.

structure was investigated using X-ray diffractometer. The chemical composition of film was characterized by EDS(Energy Dispersive Spectroscopy) analysis.

#### 3. Results

Fig. 1 shows the changes of deposition rate as a function of the distance between target and substrate. The sputtering was performed for 1hr under 100Watt DC power, 4sccm Ar flow rate. The deposition rate increased as decreasing the target-to-substrate distance.

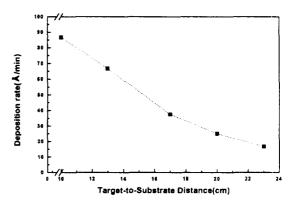


Fig. 1 The changes of deposition rate with Target-to-Substrate distance for the TiNi film prepared under the 100Watt DC power, 4sccm Ar flow rate.

#### 수소에너지 제 10권 제 4호(1999년 12월)

Fig. 2 shows the change of Nickel concentration in Til-xNix film with the target-to-substrate distance. The chemical composition of TiNi changed with the target-to-substrate distance. The Ti<sub>49.7</sub>Ni<sub>50.3</sub> film could be obtained in the 17cm target-substrate distance. This was similar as the Carchano's result that the composition of TiNi film changed as a function of product of deposition pressure and target-to-substance distance (8). This might be related with the loss of the elementary species during transport from the target to the substrate.

Fig. 3 represents the changes of the X-ray diffraction patterns of the TiNi thin film by vacuum heat treatments. The film deposited for 1hr under 10cm was target-to-substrate distance, 200Watt DC power and 12 sccm Ar flow rate. For the deposited TiNi film room there was temperature, no sharp diffraction peak. The film amorphous structure. The crystallization behavior could be showed above 600°C heat treatment in a vacuum. After 800°C vacuum heat treatment. the represented the Ti<sub>2</sub>Ni crystalline structure.

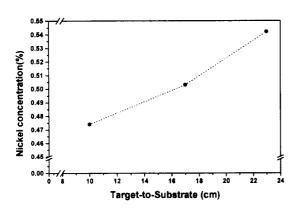


Fig. 2 The change of Nickel concentration in  $Ti_{1 x}Nix$  film as a function of target-to-substrate distance.

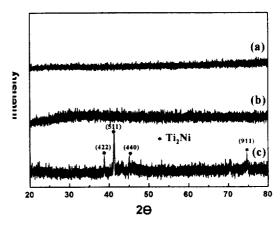


Fig. 3 The effect of vacuum heat treatment on the crystal structure of TiNi thin film

- (a) as deposition at room temperature
- (b) vacuum heat treatment at  $600\,^{\circ}\mathrm{C}$  for  $0.5\mathrm{hr}$

Fig. 4 shows the SEM result of TiNi film deposited on the stainless steel substrate. There was no special phase on the surface.

Fig. 4 The SEM morphology of TiNi thin film deposited on the stainless steel sheet substrate

In order to obtain optimum sputtering condition, TiNi film were prepared under various Ar flow rates and DC powers. The effect of Ar flow rates on the deposition rate are shown in Fig. 5. The film was prepared for 1hr under the 10cm target-to-substrate distance and 100Watt DC power. The deposition rate decreased as increasing the Ar flow rate.

Fig. 6 represents the changes of deposition rates as a DC power. The deposition rate increased as increasing DC power. The maximum rate of 297 Å/min was obtained at the highest DC power, 250 Watt and 10cm target-to-substrate distance. This phenomena might be related with the changes of sputtering yield as a power.

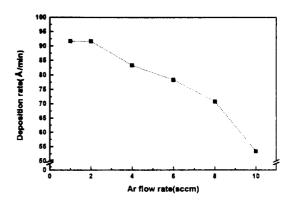


Fig. 5 The variations of deposition rate as a function of Ar flow rate for the TiNi film prepared under the 10cm target-to-substrate distance and 100Watt DC power.

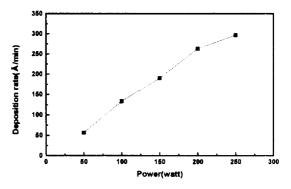


Fig. 6 The change of deposition rate as a function of DC power for the TiNi film prepared under the 2sccm Ar flow rate and 10cm target-to-substrate distance.

We have studied the electrochemical properties of Ti-Ni thin film. However, we could not find any charge - discharge behavior in the cell of Pt/6M KOH/Ti-Ni

film. order investigate In to electrochemical properties of Ti-Ni alloy. the TiNi electrode made by TiNi powder. Fig. 7 showed the 1st discharge curve of TiNi powder electrode. The discharge capacity was 63mAh/g, which was relatively low. Fig. 8 represented the initial cycle test results. The capacity increased to 87mAh/g as increasing the cycle number. Although the capacity of TiNi powder electrode was very low, it represented a typical metal hydride electrode behavior. So. it is necessary for TiNi thin film to study further electrode.

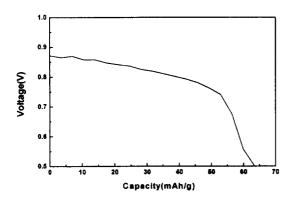


Fig. 7 The 1st discharge curve of TiNi powder electrodes.

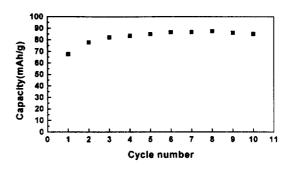


Fig. 8 The effect of charge-discharge cyclings of TiNi powder electrode on the discharge capacities.

#### 4. Conclusion

- 1. The deposition rate of TiNi thin film increased by increasing the DC power and by decreasing the Ar flow rate and target-to-substrate distance. The maximum deposition rate 297 Å/min, were obtained at 250Watt DC power.
- 2. The crystal structure of as deposited film was amorphous state, and changed to  $Ti_2Ni$  crystalline structure under vacuum heat treatment at  $800\,^{\circ}\text{C}$ . The nickel chemical composition of  $Ti_{1-x}Ni_x$  was changed by sputtering condition,  $Ti_{49.7}Ni_{50.3}$  were obtained at 17cm target-to-substrate.

#### **ACKNOWLEDGEMENT**

The authors wish to acknowledge the financial support of the Korea Research Foundation made in the program year of 1998

#### REFERENCES

- 1. F.E.Lynch, Journal of the Less-common Metals, 174 (1991) 943
- N.Kumagai, H.Kitamoto, M.Baba,
  S.Durand-Vidal, D.Devilliers, H.Groult,
  J.Appl. Electrochem., 28 (1998) 41
- 3. Y.Ratieuville, B.L.Wu, D.Lincot, J.Vedel, L.T.Yu, J.Electrochem., 146 (1999) 3161
- 4. T.Sakai, H.Ishikawa, H.Miyamurea and T.Iwasaki, J. Electrochem. Soc., 138 (1991) 908
- N.Kuriyama, T.Sakai, and H.Ishikawa,
  J. Solid State Ionics, 56 (1992) 688
- A.Ishida, M.Sato, A.Takei, K.Nomura, and S.Miyazaki, Met. Mat. Trans. A 27A (1996) 3753
- 7. A.Ishida, A.Takei and S.Miyazaki, Thin Solid Films 228 (1993) 210
- M.Bendahan, P.Canet, J.L.Seguin,
  H.Carchano, Material Science and
  Engineering, B34 (1995) 112